Certificate of Analysis

ULTRAgrade™ Solution
Titanium ICP / ICP-MS Standard
1000 µg/mL

Catalog Number: ICP-022
Lot Number: T00684
Job Number: J00018395
Lot Issue Date: 06/09/2014
Expiration Date: 07/31/2021

Starting Material:	ammonium hexafluorotitanate (IV)
Starting Material Purity:	99.998%
Starting Material Lot #:	BH01796
Matrix:	2% nitric acid, with trace hydrofluoric acid, in low TOC water (< 50 ppb)
Atomic Weight Ti:	47.90

Certified Value: 1002 ± 2 µg/mL

This Certified Reference Material (CRM) was manufactured and verified in accordance with ULTRA's ISO 9001 registered quality system. The analyte concentration(s) were prepared and verified by an ISO Guide 34 / ISO 17025 accredited laboratory, and compared to calibration standards independently prepared using NIST SRM(s). The certified value and uncertainty value at the 95% confidence level for each analyte is determined gravimetrically.

Classical Wet Assay Method: Theoretical, based on gravimetric measurements

Confirmation by Inductively Coupled Plasma Spectroscopy (ICP / ICP/MS) vs. NIST SRM 3162a

ULTRA uses purified acids, 18 megohm double deionized water, calibrated Class A glassware & meticulously cleaned bottles in the manufacturing of ULTRAgrade standards. Balances used in the manufacturing of this standard are calibrated with weights traceable to NIST in compliance with ANSI/NCSL Z-540-1 and ISO 9001.

Trace Metallic Impurities in Solution Standard in µg/mL:

*	Al	<0.005	ND	*	Ga	<0.005	ND	n	Nb			n	S		
*	Sb	<0.005	ND	n	Ge			n	Os			n	Ta		
*	As	<0.005	ND	n	Au			*	Pd	<0.005	ND	n	Te		
*	Ba	<0.005	ND	n	Hf			*	P	<0.005	ND	n	Tb		
*	Be	<0.005	ND	n	Ho			*	Pt	<0.005	ND	*	Tl	<0.005	ND
*	Bi	<0.005	ND	*	In	<0.005	ND	*	K	<0.005	ND	n	Th		
*	B	<0.005	ND	n	Ir			n	Pr			n	Tm		
*	Cd	<0.005	ND	*	Fe	<0.005	ND	n	Re			*	Sn	<0.005	ND
*	Ca	<0.005	ND	*	La	<0.005	ND	n	Rh			s	Ti		
n	Ce			*	Pb	<0.005	ND	n	Rb			n	W		
n	Cs			*	Li	<0.005	ND	n	Ru			n	U		
*	Cr	<0.005	ND	n	Lu			n	Sm			*	V	<0.005	ND
*	Co	<0.005	ND	*	Mg	<0.005	ND	n	Sc			n	Yb		
*	Cu	<0.005	ND	*	Mn	<0.005	ND	*	Se	<0.005	ND	n	Y		
n	Dy			*	Hg	<0.005	ND	*	Si	<0.005	ND	*	Zn	<0.005	ND
*	Er	<0.005	ND	*	Mo	<0.005	D	*	Ag	<0.005	ND	n	Zr		
*	Eu	<0.005	ND	n	Nd			*	Na	<0.005	ND				
*	Gd	<0.005	ND	*	Ni	<0.005	ND	*	Sr	<0.005	ND				

* - element checked for
ND – not detected
I – spectral interference
D – detected
n – not checked for
s – solution standard element

Density of Solution (measured at 20.00°C ± 0.05°C): 1.0113 g/mL

ACCREDITED

ISO 17025:2005
Accredited
A2LA
Cert. No. 0851.01

ISO 9001:2000
Registered
TUV USA, Inc.
Cert. No. 06-1004

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